


<b>Search Notes</b>  	<b>Application/Control No.</b>  10065570	<b>Applicant(s)/Patent Under Reexamination</b>  KHAN ET AL.
	<b>Examiner</b>  Pardo, Thuy N	<b>Art Unit</b>  2165

SEARCHED			
Class	Subclass	Date	Examiner
705	8	5/25/2007	TP
707	101, 102, 103R	5/25/2007	TP
717	126	5/25/2007	TP
382	149	5/25/2007	

SEARCH NOTES			
Search Notes		Date	Examiner
WEST		5/25/2007	TP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner